

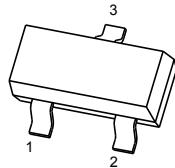
SOT-23 Plastic-Encapsulate MOSFETS

20V P-Channel MOSFET

V_{(BR)DSS}	R_{DS(on)Typ}	I_{D Max}
-20V	37mΩ@ -4.5V	-4.8A
	43mΩ@ -3.3V	

SOT-23

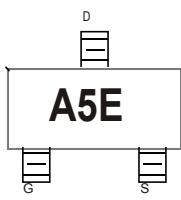
1. GATE
2. SOURCE
3. DRAIN



Features

- Excellent R_{DS(ON)}, low gate charge, low gate voltages

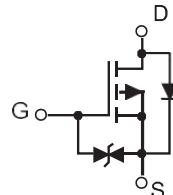
MARKING



APPLICATION

- Load switch and in PWM applications

Equivalent circuit



PACKAGE SPECIFICATIONS

Package	Reel Size	Reel DIA. (mm)	Q'TY/Reel (pcs)	Box Size mm)	Q'TY/Box (pcs)	Carton Size (mm)	Q'TY/Carton (pcs)
SOT-23	7'	178	3000	203×203×195	45000	438×438×220	180000

Maximum Ratings and Thermal Characteristics (TA = 25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{(BR)DSS}	-20	V
Gate-Source Voltage	V _{GS}	±8	
Continuous Drain Current T _A = 25 °C	I _D	-4.8	A
T _A = 70°C		-3.6	
Pulsed Drain Current ¹⁾	I _{DM}	-30	A
Maximum Power Dissipation ²⁾ T _A = 25 °C	P _D	1.5	W
T _A = 70°C		1.0	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-50 to 150	°C
Junction-to-Ambient Thermal Resistance (PCB mounted) ²⁾	R _{thJA}	80	°C/W

Notes

¹⁾ Pulse width limited by maximum junction temperature.

²⁾ Surface Mounted on FR4 Board, t ≤ 5 sec.

The above data are for reference only.

T_a=25 °C unless otherwise specified

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
Static Parameters						
Drain-source breakdown voltage	V _{(BR) DSS}	V _{GS} = 0V, I _D = -250μA	-20			V
Gate threshold voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = -250μA	-0.4	-0.7	-1.2	
Zero gate voltage drain current	I _{DSS}	V _{DS} = 20V, V _{GS} = 0V (TA=25°C)			-1	μA
		V _{DS} = 16V, V _{GS} = 0V (TA=125°C)			-100	
Gate-body leakage current	I _{GSS}	V _{DS} = 0V, V _{GS} = ±8V			±10	
Drain-source on-state resistance(note1)	R _{DS(on)}	V _{GS} = -4.5V, I _D = 4A		37	45	mΩ
		V _{GS} = -3.3V, I _D = -3A		43	55	
		V _{GS} = -2.5V, I _D = -2A		52	65	
Forward transconductance(note2)	g _{FS}	V _{DS} = -5V, I _D = -4A	8			S
Dynamic Parameters (note3)						
Input capacitance	C _{iss}	V _{DS} = -10V, V _{GS} = 0V, f = 1MHz		675		pF
Output capacitance	C _{oss}			120		
Reverse transfer capacitance	C _{rss}			85		
Gate resistance	R _g	V _{DS} = 0V, V _{GS} = 0V, f = 1MHz		6.5		Ω
Switching Parameters						
Total gate charge	Q _g	V _{DS} = -10V, V _{GS} = -4.5V, I _D = -4A		14.2		nC
Gate-Source charge	Q _{gs}			3.2		
Gate-drain charge	Q _{gd}			5.8		
Turn-on delay time (note3)	t _{d(on)}	V _{DS} = -10V, V _{GS} = -4.5V R _{GEN} = 3Ω, R _L = 2.5Ω,		15		ns
Turn-on rise time(note3)	t _r			11		
Turn-off delay time(note3)	t _{d(off)}			22		
Turn-off fall time(note3)	t _f			35		
Drain-source body diode characteristics						
Continuous source-drain diode current	I _s	T _c = 25°C			-2.0	A
Body diode voltage (note 2)	V _{SD}	I _s = -2A, V _{GS} = 0V		-0.83	-1.2	V

Notes:

^{1,2} Repetitive rating, pulse width limited by junction temperature.

³ Pulse test: pulse width ≤ 300us, duty cycle≤ 2%.

These parameters have no way to verify.

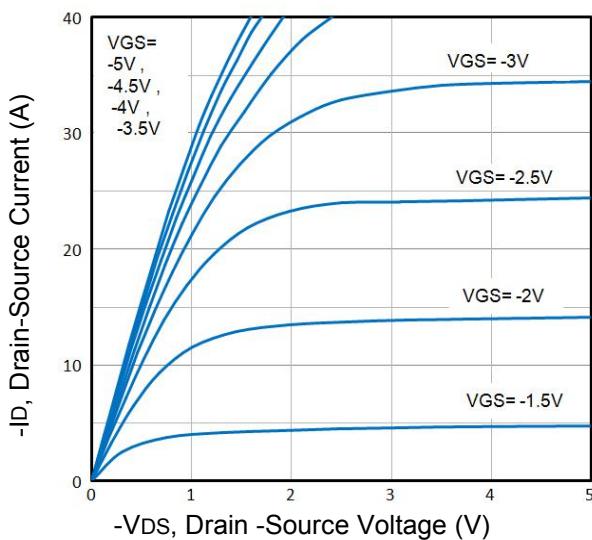


Fig1. Typical Output Characteristics

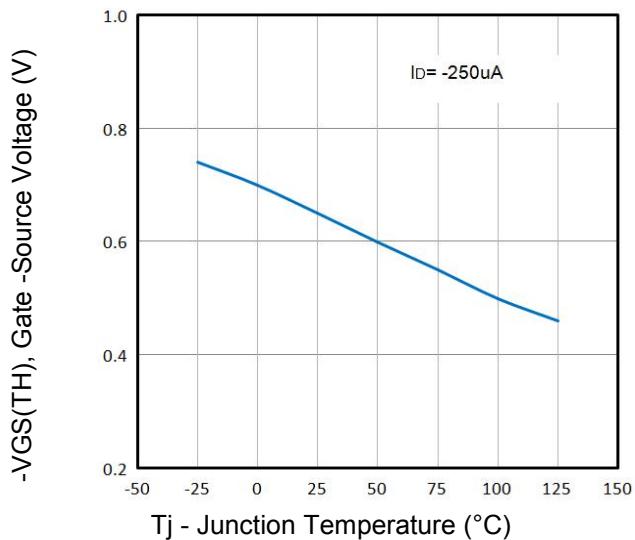


Fig2. Normalized Threshold Voltage Vs. Temperature

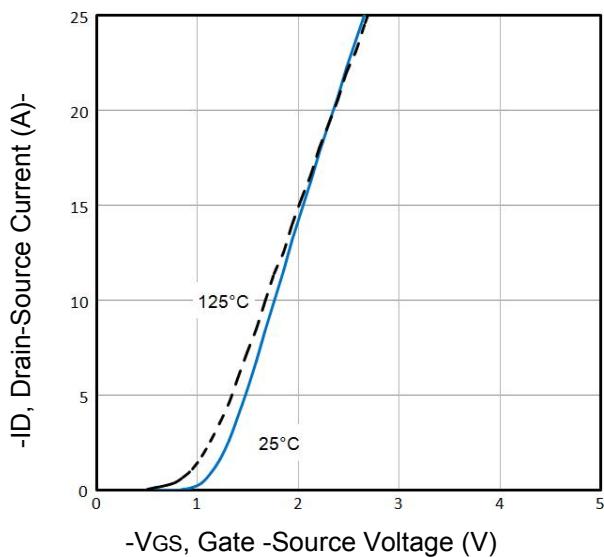


Fig3. Typical Transfer Characteristics

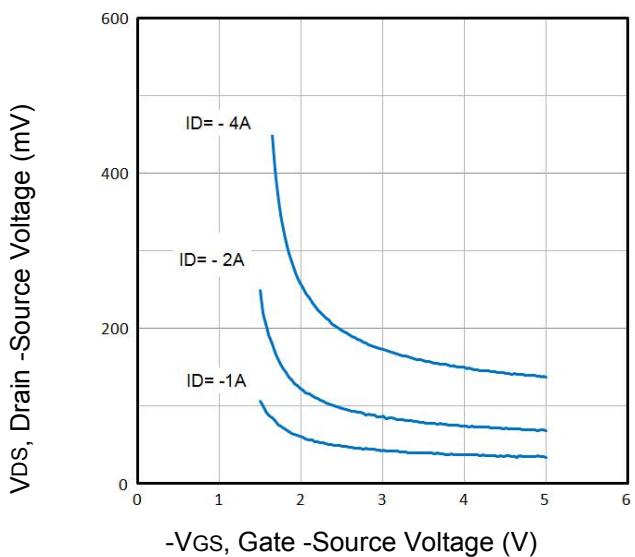


Fig4. Drain -Source Voltage vs Gate -Source Voltage

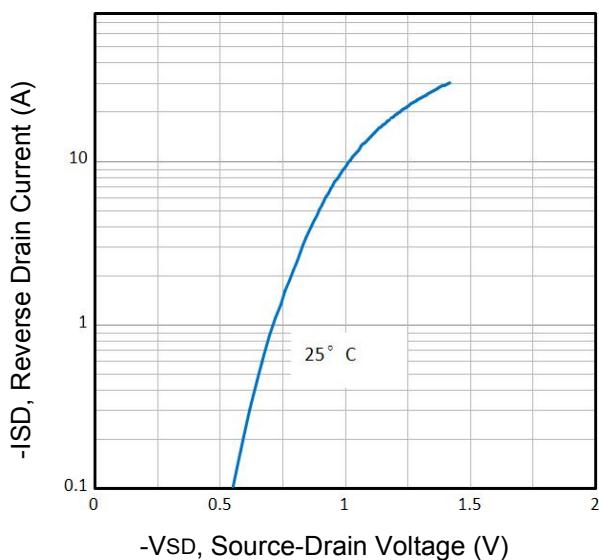


Fig5. Reverse Drain Current vs Source-Drain Voltage

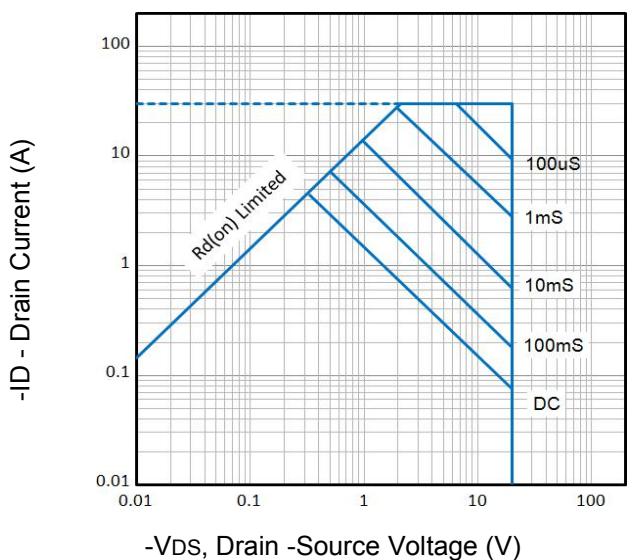


Fig6. Maximum Safe Operating Area

Typical Characteristics

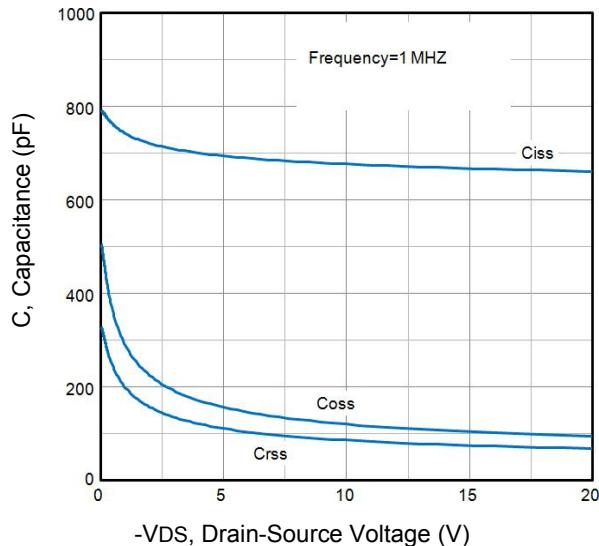


Fig7. Typical Capacitance Vs. Drain-Source Voltage

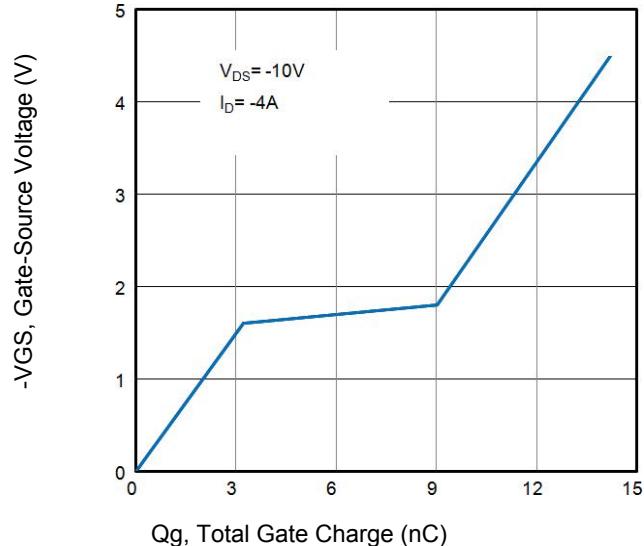


Fig8. Typical Gate Charge Vs. Gate-Source Voltage

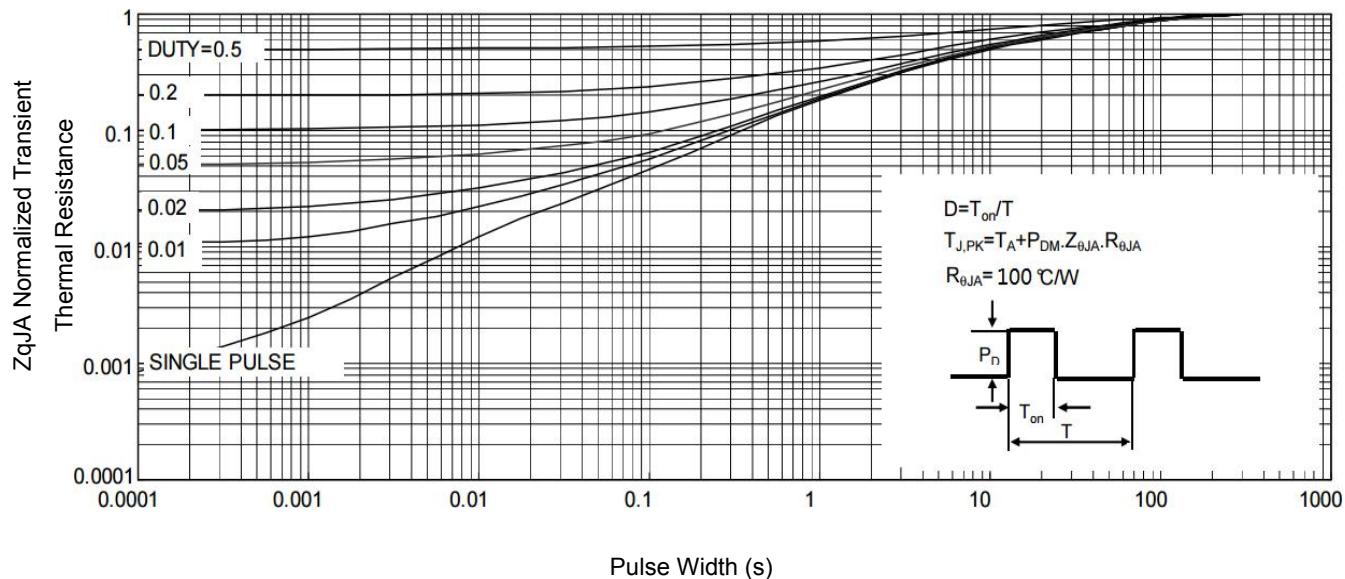


Fig9. Normalized Maximum Transient Thermal Impedance

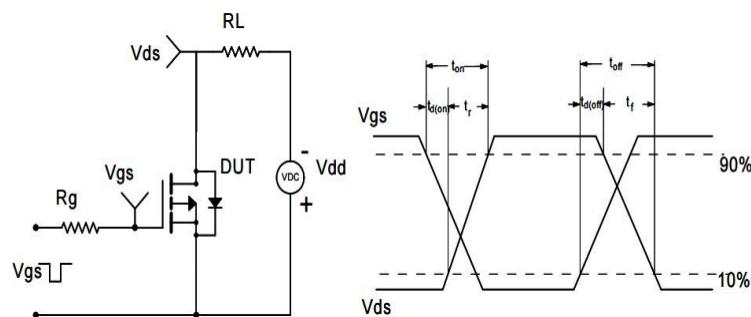
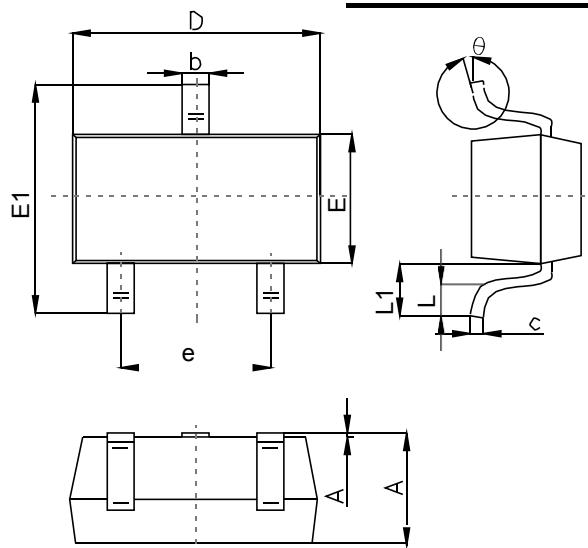


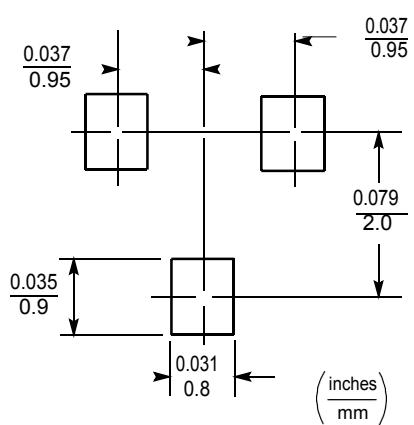
Fig10. Switching Time Test Circuit and waveforms

SOT-23 Package Outline Dimensions



Symbol	Dimensions In Millimeters		
	Min	Typ	Max
A	1.00		1.40
A1			0.10
b	0.35		0.50
c	0.10		0.20
D	2.70	2.90	3.10
E	1.40		1.60
E1	2.4		2.80
e		1.90	
L	0.10		0.30
L1	0.4		
θ	0°		10°

Suggested Pad Layout



Note:1
Controlling dimension:in/millimeters. 2.General tolerance: $\pm 0.05\text{mm}$.
3.The pad layout is for reference purposes only.